



OPA4323, OPA323, OPA2323

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OPAx323 20MHz 高帯域幅、114dB CMRR、低電圧 (1.7V~5.5V)、RRIO ゼロ クロ スオペアンプ

1 特長

- 1.7V~5.5V アプリケーション用ゼロ クロス アンプ
- 大きいレール ツー レール CMRR: 114dB (標準値)
- 高ゲイン帯域幅積:20MHz
- 高速スルーレート:標準値 33V/us
- 高速 0.01% セトリング:標準値 200ns (2V 刻みの場
- 低い入力オフセット電圧:±150µV (標準値)
- 低ノイズ フロア:標準値 5.5nV/√Hz (10kHz 時)
- 大出力電流:標準値 ±110mA の I_{SC} (5.5V 時)
- 静止電流:1.6mA/チャネル (標準値)
- レール ツー レール入出力
- ユニティゲイン安定
- 持続的な発振なしで最大 150pF を駆動
- 内部 RFI および EMI フィルタ付きの入力ピン
- 動作温度範囲:-40℃~125℃

2 アプリケーション

- ADC 用アンプ・ドライバ
- ハイサイド電流センス
- モータ・ロータリー・エンコーダ
- トランスインピーダンス・フォトダイオード・アンプ
- オーディオ・マイクロフォン・プリアンプ
- 超音波トランスデューサ

3 概要

OPAx323 ファミリのオペアンプには、ゼロクロスオーバー 入力段とレール ツー レール出力段を備えた、シングル (OPA323)、デュアル (OPA2323)、クワッド チャネル (OPA4323)、低電圧 (1.7V~5.5V)、広帯域 (20MHz) ア ンプがあります。ゼロクロスオーバー入力段により、 OPAx323 は ADC ドライバ アプリケーションで一般的なレ ールツーレールスイングを備えた入力信号について、高 い直線性と低い歪みを実現できます。 20MHz のゲイン帯 域幅により、必要なセトリング性能に応じて 0.5MSPS~ 5MSPS の ADC サンプリング速度で、高速なセトリング応 答が得られます。OPAx323 は、標準値の静止電流がわ ずか 1.6mA であり、消費電力削減に最適化されていま す。

OPAx323 は、最大オフセットドリフト 2µV/℃および最小 100dB の CMRR で、熱ノイズ フロア 5.5nV/rt-Hz を備え ているため、ホイートストン ブリッジなど高ゲインの電圧セ ンシング アプリケーションで、高精度の性能を簡単にサポ ートします。より高い精度(低オフセット、ドリフト、ノイズ、歪 み、CMRR)と、より高いゲイン帯域幅(高速セトリングとス ルーイング)の独特な組み合わせにより、モーターロータ リー エンコーダ、マイクロフォン オーディオ プリアンプ、超 音波トランスデューサなど、さまざまなアプリケーションで使 用できます。

OPAx323 は 33V/µs の高いスルーレートを実現している ため、モーター電流センシングアプリケーションでフォルト を高速検出できます。従来のアンプとは異なり、ゼロクロス オーバー入力段により、ローサイドとハイサイド両方のセン シング アプリケーションで同一の精度性能が得られるた め、OPAx323 はソーラー ストリング インバータ、電力供 給、グリッド、EV インフラストラクチャなどさまざまな最終機 器の電流センシングに最適です。OPAx323S デバイスに はシャットダウン機能があり、さらに消費電力を削減し、ア イドル時にアンプをディセーブルできます。このファミリに は、すべてのチャネル バリアントで標準サイズと小型サイ ズに加えて、リード付きおよび QFN パッケージがありま

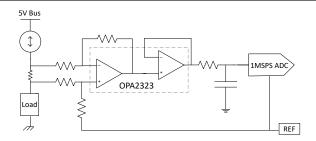
製品情報

| 部品番号(1) | チャネル数 | パッケージ ⁽⁴⁾ | パッケージ サイズ(5) |
|--------------|--|--------------------------------|----------------|
| | | DBV (SOT-23, 5) (3) | 2.9mm × 2.8mm |
| OPA323 | シングル | DCK (SC70, 5) | 2mm × 1.25mm |
| | | DRL (SOT-5X3, 5) (3) | 1.6mm × 1.6mm |
| OPA323S (2) | シングル、シャットダウン | DBV (SOT-23, 6) (3) | 2.9mm × 2.8mm |
| OFA3233 (7 | \(\sigma \sigma \range \ran | DCK (SC70, 6) (3) | 2mm × 1.25mm |
| | | D (SOIC, 8) | 4.9mm × 6mm |
| | | DDF (SOT-23, 8) | 2.9mm × 2.8mm |
| OPA2323 | デュアル | DSG (WSON, 8) (3) | 2mm × 2mm |
| | | DGK (VSSOP, 8) | 3mm × 4.9mm |
| | | PW (TSSOP, 8) (3) | 3mm × 6.4mm |
| OPA2323S (2) | デュアル、シャットダウン | RUG (X2QFN, 10) (3) | 1.5mm × 2mm |
| | | D (SOIC, 14) (3) | 8.65mm × 6mm |
| OPA4323 | hm 18 | PW (TSSOP, 14) | 5mm × 6.4mm |
| OFA4323 | クワッド | RUC (X2QFN, 14) ⁽³⁾ | 2mm × 2mm |
| | | DYY (SOT-23, 14) | 4.2mm × 3.26mm |
| OPA4323S (2) | クワッド、シャットダウン | RTE (WQFN, 16) (3) | 3mm × 3mm |

- (1) セクション 4 を参照してください。
- (2) 部品番号はプレビュー専用です。
- (3) パッケージはプレビュー専用です。
- 詳細については、セクション 11 を参照してください。
- パッケージ サイズ (長さ×幅) は公称値であり、該当する場合はピ ンも含まれます。

English Data Sheet: SBOSAE8





双方向、ハイサイド電流センス アンプと ADC ドライバ



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4 Device Comparison Table

| | NO. OF | PACKAGE LEADS | | | | | | | | | | | |
|------------------------|----------|---------------|-------------|-----------|------------------------------|---------------|-------------------------------|---------------|-------------|--------------|-----------------|----------------------------|-----------------------------|
| DEVICE | CHANNELS | | SC70 DCK | SOIC D | SOT-23 DBV ⁽²⁾ | SOT-23 DDF | SOT-553 DRL ⁽²⁾ | SOT-23 DYY | TSSOP PW | VSSOP DGK | WQFN RTE (2) | WSON DSG ⁽²⁾ | X2QFN RUG ⁽²⁾ |
| OPA323 | 1 | NO | 5 | _ | 5 | _ | 5 | _ | _ | _ | _ | _ | _ |
| OPA323S ⁽¹⁾ | 1 | YES | 6 | _ | 6 | _ | _ | _ | _ | _ | _ | _ | _ |
| OPA2323 | 2 | NO | _ | 8 | _ | 8 | _ | _ | 8 | 8 | _ | 8 | _ |
| OPA2323S(1) | 2 | YES | _ | _ | _ | _ | _ | _ | _ | _ | _ | _ | 10 |
| OPA4323 | 4 | NO | _ | 14 | _ | _ | _ | 14 | 14 | _ | _ | _ | _ |
| OPA4323S | 4 | YES | _ | _ | _ | _ | _ | _ | _ | _ | 16 | _ | _ |

- (1) Devices are preview only.
- (2) Packages are preview only.



5 Pin Configuration and Functions

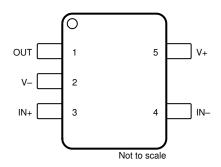


図 5-1. OPA323 DBV Package, 5-Pin SOT-23 (Top View)

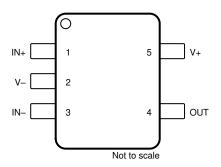


図 5-2. OPA323 DCK and DRL Package, 5-Pin SC70 and 5-Pin SOT-5X3 (Top View)

表 5-1. Pin Functions: OPA323

| | PIN | | TYPE ⁽¹⁾ | DESCRIPTION | |
|------|--------|---------------|---------------------|---|--|
| NAME | SOT-23 | SC70, SOT-5X3 | TIPE | DESCRIPTION | |
| IN- | 4 | 3 | I | Inverting input | |
| IN+ | 3 | 1 | I | Noninverting input | |
| OUT | 1 | 4 | 0 | Output | |
| V- | 2 | 2 | I | Negative (low) supply or ground (for single-supply operation) | |
| V+ | 5 | 5 | I | Positive (high) supply | |



図 5-3. OPA323S DBV Package, 6-Pin SOT-23 (Top View)

図 5-4. OPA323S DCK Package, 6-Pin SC70 (Top View)

表 5-2. Pin Functions: OPA323S

| PIN | | | TYPE ⁽¹⁾ | DESCRIPTION | |
|------|--------|------|---------------------|---|--|
| NAME | SOT-23 | SC70 | 1166 | DESCRIP HON | |
| IN- | 4 | 3 | I | Inverting input | |
| IN+ | 3 | 1 | I | Noninverting input | |
| OUT | 1 | 4 | 0 | Output | |
| SHDN | 5 | 5 | I | Shutdown: low = amp disabled, high = amp enabled See Shutdown Function for more information | |
| V- | 2 | 2 | I | Negative (low) supply or ground (for single-supply operation) | |
| V+ | 6 | 6 | I | Positive (high) supply | |



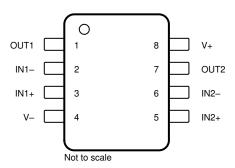
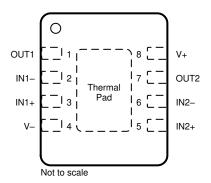


図 5-5. OPA2323 D, PW, DGK, and DDF Package, SOIC, TSSOP, VSSOP, and SOT-23-THIN (Top View)



Connect exposed thermal pad to V–. For more information, see *Packages with an Exposed Thermal Pad*.

図 5-6. OPA2323 DSG Package, 8-Pin WSON with Exposed Thermal Pad (Top View)

表 5-3. Pin Functions: OPA2323

| F | PIN | | | |
|------|--|---------------------|---|--|
| NAME | SOIC, TSSOP, VSSOP, SOT-23-THIN, WSON | TYPE ⁽¹⁾ | DESCRIPTION | |
| IN1- | 2 | I | Inverting input, channel 1 | |
| IN1+ | 3 | I | Noninverting input, channel 1 | |
| IN2- | 6 | I | Inverting input, channel 2 | |
| IN2+ | 5 | I | Noninverting input, channel 2 | |
| OUT1 | 1 | 0 | Output, channel 1 | |
| OUT2 | 7 | 0 | Output, channel 2 | |
| V- | 4 | I | Negative (low) supply or ground (for single-supply operation) | |
| V+ | 8 | I | Positive (high) supply | |



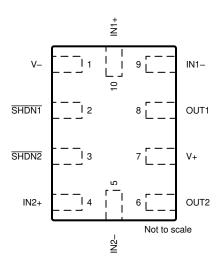


図 5-7. OPA2323S RUG Package 10-Pin X2QFN (Top View)

表 5-4. Pin Functions: OPA2323S

| PIN | | TYPE ⁽¹⁾ | DESCRIPTION | | |
|-------|-------|---------------------|---|--|--|
| NAME | X2QFN | ITPE | DESCRIPTION | | |
| IN1- | 9 | I | Inverting input, channel 1 | | |
| IN1+ | 10 | I | Noninverting input, channel 1 | | |
| IN2- | 5 | I | Inverting input, channel 2 | | |
| IN2+ | 4 | I | Noninverting input, channel 2 | | |
| OUT1 | 8 | 0 | Output, channel 1 | | |
| OUT2 | 6 | 0 | Output, channel 2 | | |
| SHDN1 | 2 | I | Shutdown: low = amp disabled, high = amp enabled, channel 1. For more information, see <i>Shutdown Function</i> . | | |
| SHDN2 | 3 | I | Shutdown: low = amp disabled, high = amp enabled, channel 2 For more information, see <i>Shutdown Function</i> . | | |
| V- | 1 | I | legative (low) supply or ground (for single-supply operation) | | |
| V+ | 7 | I | Positive (high) supply | | |



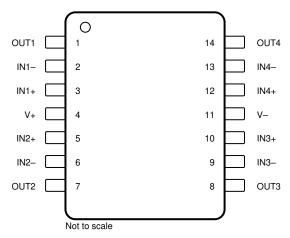
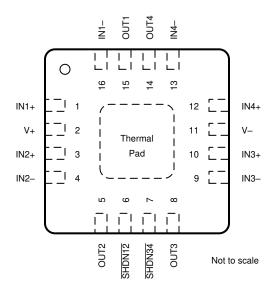


図 5-8. OPA4323 D, PW and DYY Package, 14-Pin SOIC, TSSOP, SOT-23-THN (Top View)

表 5-5. Pin Functions: OPA4323

| | PIN | TYPE ⁽¹⁾ | DESCRIPTION | |
|------|-------------|---------------------|---|--|
| NAME | SOIC, TSSOP | ITPE | DESCRIPTION | |
| IN1- | 2 | I | Inverting input, channel 1 | |
| IN1+ | 3 | 1 | Noninverting input, channel 1 | |
| IN2- | 6 | I | Inverting input, channel 2 | |
| IN2+ | 5 | I | Noninverting input, channel 2 | |
| IN3- | 9 | I | Inverting input, channel 3 | |
| IN3+ | 10 | I | Noninverting input, channel 3 | |
| IN4- | 13 | I | Inverting input, channel 4 | |
| IN4+ | 12 | I | Noninverting input, channel 4 | |
| OUT1 | 1 | 0 | Output, channel 1 | |
| OUT2 | 7 | 0 | Output, channel 2 | |
| OUT3 | 8 | 0 | Output, channel 3 | |
| OUT4 | 14 | 0 | Output, channel 4 | |
| V- | 11 | I | Negative (low) supply or ground (for single-supply operation) | |
| V+ | 4 | I | Positive (high) supply | |



A. Connect thermal pad to V-.

図 5-9. OPA4323S RTE Package, 16-Pin WQFN With Exposed Thermal Pad (Top View)

表 5-6. Pin Functions: OPA4323S

| P | IN | - (1) | 2 0 0.1 III 1 dilottorio. Ol A40200 |
|--------|------|---------------------|---|
| NAME | WQFN | TYPE ⁽¹⁾ | DESCRIPTION |
| IN1+ | 1 | I | Noninverting input, channel 1 |
| IN1- | 16 | I | Inverting input, channel 1 |
| IN2+ | 3 | ı | Noninverting input, channel 2 |
| IN2- | 4 | I | Inverting input, channel 2 |
| IN3+ | 10 | ı | Noninverting input, channel 3 |
| IN3- | 9 | I | Inverting input, channel 3 |
| IN4+ | 12 | I | Noninverting input, channel 4 |
| IN4- | 13 | ı | Inverting input, channel 4 |
| SHDN12 | 6 | I | Shutdown: low = amp disabled, high = amp enabled, channel 1 and 2. For more information, see <i>Shutdown Function</i> . |
| SHDN34 | 7 | I | Shutdown: low = amp disabled, high = amp enabled, channel 3 and 4. For more information, see <i>Shutdown Function</i> . |
| OUT1 | 15 | 0 | Output, channel 1 |
| OUT2 | 5 | 0 | Output, channel 2 |
| OUT3 | 8 | 0 | Output, channel 3 |
| OUT4 | 14 | 0 | Output, channel 4 |
| V- | 11 | I | Negative (low) supply or ground (for single-supply operation) |
| V+ | 2 | I | Positive (high) supply |



6 Specifications

6.1 Absolute Maximum Ratings

over operating ambient temperature range (unless otherwise noted) (1)

| | 1 0 1 | | | | |
|---------------------------------------|--|----------------|--------|--|--|
| | | MIN MA | X UNIT | | |
| Supply voltage, $V_S = (V+) - (V-)$ | Supply voltage, V _S = (V+) – (V–) | 0 7 | 0 V | | |
| | Common-mode voltage (2) (3) | - 0.5 | 0 V | | |
| Signal input pins | Differential voltage (2) (3) | ±6 | 0 V | | |
| | Current (3) | -10 1 | 0 mA | | |
| Output short-circuit (4) | | Continuous | | | |
| Operating ambient temperature, | T _A | -55 15 | 0 °C | | |
| Junction temperature, T _J | | 15 | 0 °C | | |
| Storage temperature, T _{stg} | | – 65 15 | 0 °C | | |

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) Input pins can swing beyond (V+) as long as they stay with in 6V. No diode structure from input pins to (V+).
- (3) Input pins are diode-clamped to (V–). Input signals that 0.3V below (V–) must be current-limited to 10mA or less.
- (4) Short-circuit to ground, one amplifier per package.

6.2 ESD Ratings

| | | | | VALUE | UNIT |
|--------------------|-------------------------|--|-----------------|-------|------|
| | | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1) | | ±4000 | V |
| V _(ESD) | Electrostatic discharge | Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 (2) | OPA4323 | ±500 | V |
| | | Charged-device filoder (CDIVI), per ANSI/ESDA/JEDEC 35-002 | OPA323, OPA2323 | ±250 | V |

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

| | | MIN | MAX | UNIT |
|------------------|---|-----|-----|------|
| Vs | Supply voltage, (V+) – (V–) | 1.7 | 5.5 | V |
| C _{BYP} | Bypass capacitor on the power supply pins (1) | 0.1 | | μF |
| T _A | Specified temperature | -40 | 125 | °C |

(1) For C_{BYP}, use low-ESR ceramic capacitors between each supply pin and ground. Only one C_{BYP} is sufficient for single supply operation. Ensure that C_{BYP} is placed as close to the device as possible and the supply trace routes through C_{BYP} before reaching the supply pin.

6.4 Thermal Information for Single Channel

| THERMAL METRIC (1) | | | OPA323 | | OPA | | |
|-----------------------|--|--|--------|---------------------------------|--------------------------------|------------------------------|------|
| | | THERMAL METRIC (1) DBV (2) DCK (SOT-23) (SC70) | | DRL ⁽²⁾ (SOT-5X3) | DBV ⁽²⁾ (SOT-23) | DCK ⁽²⁾ (SC70) | UNIT |
| | | 5 PINS | 5 PINS | 5 PINS | 6 PINS | 6 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 189.3 | 196.7 | TBD | 168.8 | TBD | °C/W |
| R _{0JC(top)} | Junction-to-case (top) thermal resistance | 86.9 | 104.5 | TBD | 87.8 | TBD | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 55.9 | 44.8 | TBD | 49.3 | TBD | °C/W |
| ΨЈТ | Junction-to-top characterization parameter | 23.7 | 18.7 | TBD | 25.6 | TBD | °C/W |
| ΨЈВ | Junction-to-board characterization parameter | 55.5 | 44.5 | TBD | 49.0 | TBD | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | n/a | n/a | TBD | n/a | TBD | °C/W |

 For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report. (2) This package option is preview.

6.5 Thermal Information for Dual Channel

| | | | OPA2323S | | | | | |
|-----------------------|--|------------|------------------------------|----------------|-------------------|------------------------------|-------------------------------|------|
| THERMAL METRIC (1) | | D (SOIC | PW ⁽²⁾ (TSSOP) | DGK (VSSOP) | DDF (SOT-23-8) | DSG ⁽²⁾ (WSON) | RUG ⁽²⁾ (X2QFN) | UNIT |
| | | 8 PINS | 8 PINS | 8 PINS | 8 PINS | 8 PINS | 10 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 139.0 | TBD | 173.6 | 149.6 | TBD | 144.8 | °C/W |
| R _{θJC(top)} | Junction-to-case (top) thermal resistance | 81.2 | TBD | 65.1 | 72.9 | TBD | 47.1 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 82.4 | TBD | 95.1 | 68.4 | TBD | 76.0 | °C/W |
| Ψυτ | Junction-to-top characterization parameter | 31.3 | TBD | 10.0 | 4.0 | TBD | 0.8 | °C/W |
| ΨЈВ | Junction-to-board characterization parameter | 81.6 | TBD | 93.5 | 68.1 | TBD | 75.8 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | n/a | TBD | n/a | n/a | TBD | n/a | °C/W |

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.6 Thermal Information for Quad Channel

| THERMAL METRIC (1) | | | OPA4323 | OPA4323S | | |
|-----------------------|--|----------------------------|---------------|--------------|------------------------------|------|
| | | D ⁽²⁾ (SOIC) | PW (TSSOP) | DYY (SOT) | RTE ⁽²⁾ (WQFN) | UNIT |
| | | 14 PINS | 14 PINS | 14 PINS | 16 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | TBD | 115.8 | 113.7 | 48.7 | °C/W |
| R _{0JC(top)} | Junction-to-case (top) thermal resistance | TBD | 44.9 | 49.1 | 52.0 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | TBD | 58.7 | 42.4 | 23.9 | °C/W |
| ΨЈТ | Junction-to-top characterization parameter | TBD | 5.2 | 1.6 | 1.2 | °C/W |
| ΨЈВ | Junction-to-board characterization parameter | TBD | 58.1 | 42.2 | 23.9 | °C/W |
| $R_{\theta JC(bot)}$ | Junction-to-case (bottom) thermal resistance | TBD | n/a | n/a | 8.2 | °C/W |

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

English Data Sheet: SBOSAE8

⁽²⁾ This package option is preview.

⁽²⁾ This package option is preview.



6.7 Electrical Characteristics

For V_S = (V+) – (V–) = 1.8V to 5.5V (±0.85V to ±2.75V) at T_A = 25°C, R_L = 10k Ω connected to V_S / 2, V_{CM} = V_S / 2, and V_{OUT} = V_S / 2, unless otherwise noted.

| PA | ARAMETER | TEST CONDITIO | NS | MIN | TYP | MAX | UNIT |
|----------------------|--|---|--|------------|----------|--------------------|------------------|
| OFFSET | VOLTAGE | | | | | | |
| ., | Input offset | V _S = 1.8V to 5.5V | | | ±0.15 | ±1.25 | |
| V _{OS} | voltage | V _S = 1.8V to 5.5V | T _A = -40°C to 125°C | | | ±1.35 | mV |
| dV _{OS} /dT | Input offset voltage drift (1) | V _S = 1.8V to 5.5V | T _A = -40°C to 125°C | | ±0.4 | ±1.8 | μV/°C |
| PSRR | Input offset voltage versus power supply | voltage versus $V_S = 1.8V$ to 5.5V | | | ±5 | ±20 | μV/V |
| | Channel separation | f = 10kHz | | | ±1 | | μV/V |
| INPUT BI | AS CURRENT | | | <u>'</u> | | ' | |
| | Input bias | V _S = 1.8V and V _S = 5V | | | ±0.5 | ±20 | pA |
| I _B | current (1) | V _S = 1.8V and V _S = 5V | T _A = -40°C to 125°C | | | ±1600 | pА |
| | Input offset | V _S = 1.8V and V _S = 5V | | | ±0.25 | | pА |
| los | current (1) | $V_S = 1.8V$ and $V_S = 5V$ | T _A = -40°C to 125°C | | | ±120 | pA |
| NOISE | 1 | | 1 | | | | • |
| E _N | Input voltage noise | f = 0.1Hz to 10Hz | | | 2.8 | | μV _{PP} |
| | | f = 100Hz | | | 24 | | |
| e _N | Input voltage noise density | f = 1kHz | | 9 | | nV/√ Hz | |
| | | f = 10kHz | | 5.5 | | | |
| i _N | Input current noise (2) | f = 1 kHz | | 20 | | fA/√Hz | |
| INPUT VC | LTAGE RANGE | | | | | | |
| V _I | Input voltage range | V _S = 1.8V to 5.5V | | (V-) - 0.2 | | (V+) + 0.15 | V |
| | | $V_S = 5.5V$, $(V-) - 0.2V \le V_{CM} \le (V+) + 0.10V$ | | 100 | 114 | | dB |
| | | $V_S = 5.5V, (V-) - 0.2V \le V_{CM} \le (V+) + 0.15V$ | | 90 | 104 | | dB |
| CMRR | Common-mode rejection ratio | $V_S = 5.5V$, $(V-) - 0.2V \le V_{CM} \le (V+) + 0.15V$ | $T_A = -40^{\circ}C \text{ to } 125^{\circ}C$ | 84 | | | dB |
| | rejection ratio | $V_S = 1.8V, (V-) - 0.1V \le V_{CM} \le (V+) + 0.05V$ | | 85 | 103 | | dB |
| | | $V_S = 1.8V, (V-) - 0.1V \le V_{CM} \le (V+) + 0.05V$ | T _A = -40°C to 125°C | 80 | | | dB |
| INPUT IM | PEDANCE | | | | | l | |
| Z _{ID} | Differential | | | | 80 2 | | GΩ pF |
| Z _{ICM} | Common-mode | | | | 100 1 | | GΩ pF |
| OPEN-LO | OP GAIN | ı | | | | | |
| | | $V_S = 1.8V$, $(V-) + 0.1V < V_O < (V+) - 0.1V$, $R_L = 0.1V$ | = 10kΩ to V _S / 2 | 103 | 120 | | dB |
| | Open-loop | V _S = 1.8V, (V–) + 0.2V < V _O < (V+) – 0.2V, R _L | 100 | 115 | | dB | |
| A _{OL} | voltage gain | $V_S = 5.5V$, $(V) + 0.1V < V_O < (V_+) - 0.1V$, $R_L = 0.1V$ | | 112 | 125 | | dB |
| | | $V_S = 5.5V$, $(V-) + 0.2V < V_O < (V+) - 0.2V$, $R_L = 0.2V$ | 108 | 120 | | dB | |
| FREQUE | NCY RESPONSE | | | | | | |
| GBW | Gain-bandwidth product | $V_S = 5.5V$, $G = +1$, $R_L = 10k\Omega$, $C_L = 100pF$ | T _A = 25°C | | 20 | | MHz |
| SR | Slew rate | $V_S = 5.5V, G = +1, V_{STEP} = 5V, R_L = 10k\Omega, C_L$ | = 100pF | | 33 | | V/µs |
| THD+N | Total harmonic distortion + noise | V _S = 5V, G = +1, V _O = 4V _{P-P} , f = 10kHz, R _L = 6 | 000Ω to V _S / 2, C _L = $50pF$ | | 0.00125 | | % |
| | | To 0.1%, V _S = 5.5V, V _{STEP} = 4V, G = +1, C _L = - | | 200 | | | |
| | | To 0.1%, $V_S = 5.5V$, $V_{STEP} = 2V$, $G = +1$, $C_L = -1$ | • | | 150 | | |
| s | Settling time | | | | | ns | |
| t _S | 3 | To 0.01%, $V_S = 5.5V$, $V_{STEP} = 4V$, $G = +1$, $C_L =$ | : 10pF | | 250 | l | |

6.7 Electrical Characteristics (続き)

For V_S = (V+) – (V–) = 1.8V to 5.5V (±0.85V to ±2.75V) at T_A = 25°C, R_L = 10k Ω connected to V_S / 2, V_{CM} = V_S / 2, and V_{OUT} = V_S / 2, unless otherwise noted.

| P.A | ARAMETER | TEST CONDITION | S | MIN | TYP | MAX | UNIT |
|-----------------------|--|---|---------------------------------|------------|------------|-----------------|----------|
| GM | Gain Margin | $V_S = 5.5V, G = +1, R_L = 10k\Omega, C_L = 30pF$ | | 15 | | dB | |
| Ow Gair Margin | | $V_S = 1.8V$, $G = +1$, $R_L = 10k\Omega$, $C_L = 30pF$ | | | 15 | | dB |
| PM | Phase Margin | $V_S = 5.5V, G = +1, R_L = 10k\Omega, C_L = 30pF$ | | 50 | | 0 | |
| IVI | T flase Margin | $V_S = 1.8V$, $G = +1$, $R_L = 10k\Omega$, $C_L = 30pF$ | | | 52.5 | | 0 |
| t _{overload} | Overload recovery time | V _{IN} × gain > V _S | | | 130 | | ns |
| EMIRR | Electro-magnetic interference rejection ratio | f = 1.8GHz, V _{IN_EMIRR} = 100mV | | | 62 | | dB |
| ОИТРИТ | <u> </u> | | | • | | | |
| | | $V_S = 1.8V$, $R_L = 10k\Omega$ to $V_S / 2$ | | | 15 | 25 | mV |
| Vo | Voltage output swing from rail | $V_S = 5.5V$, $R_L = 10k\Omega$ to $V_S / 2$ | | | 25 | 35 | mV |
| | Swing from rain | $V_S = 5.5V, R_L = 2k\Omega \text{ to } V_S / 2$ | | | 45 | 55 | mV |
| | Short-circuit | V _S = 1.8V | | ±20 | ±40 | | mA |
| I _{SC} | current (4) | V _S = 5.5V | | ±80 | ±110 | | mA |
| Z _O | Open-loop output impedance | f = 10kHz | | | 80 | | Ω |
| POWER S | SUPPLY | | | • | | | |
| | Quiescent | | | | 1.6 | 1.9 | |
| IQ | current per amplifier | $V_S = 5.5V, I_O = 0A$ | T _A = -40°C to 125°C | | | 2.0 | mA |
| | Power-on time | V _S = 0V to 5.5V, 90% I _Q Level | | | 25 | | μs |
| SHUTDO | WN | | | | | | |
| | Shutdown | All amplifiers disabled, SHDN = V- | | | 0.5 | 1 | μΑ |
| I _{QSD} | current per amplifier ⁽⁷⁾ | | | | | 1.5 | μA |
| Z _{SHDN} | Output impedance during shutdown | Amplifier disabled | | | 43 11.5 | | GΩ pF |
| V_{IH} | Logic high threshold voltage (amplifier enabled) (7) | | | (V–) + 1 V | | | ٧ |
| V_{IL} | Logic low threshold voltage (amplifier disabled) | | | | | (V-) + 0.2 V | ٧ |
| | Amplifier enable time (full shutdown) (5) (6) (7) | $G = +1, V_{CM} = V_S / 2, V_O = 0.9 \times V_S / 2, R_L connection$ | | 1 | | | |
| t _{ON} | Amplifier enable time (partial shutdown) (5) (6) (7) | $G = +1$, $V_{CM} = V_S / 2$, $V_O = 0.9 \times V_S / 2$, R_L connected to V | | | 1 | | μs |
| | 1 | G = +1, V _{CM} = V _S / 2, V _O = 0.1 × V _S / 2, R _L connected to V– | | | | | |
| t _{OFF} | Amplifier disable time (5) (7) | $G = +1, V_{CM} = V_S / 2, V_O = 0.1 \times V_S / 2, R_L connection$ | ected to V- | | 1 | | μs |
| t _{OFF} | | G = +1, $V_{CM} = V_S / 2$, $V_O = 0.1 \times V_S / 2$, R_L connection (V+) $\geq \overline{SHDN} \geq (V-) + 1V$ | ected to V- | | 50 | | μs nA |

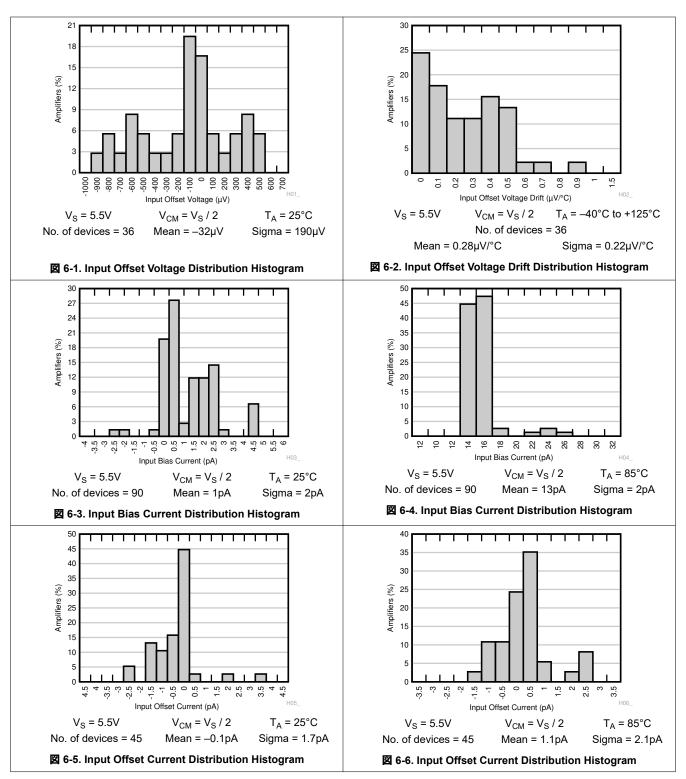
⁽¹⁾ Max or min limit is specified based on characterization results.

⁽²⁾ Typical input current noise data to be specified based on design simulation results

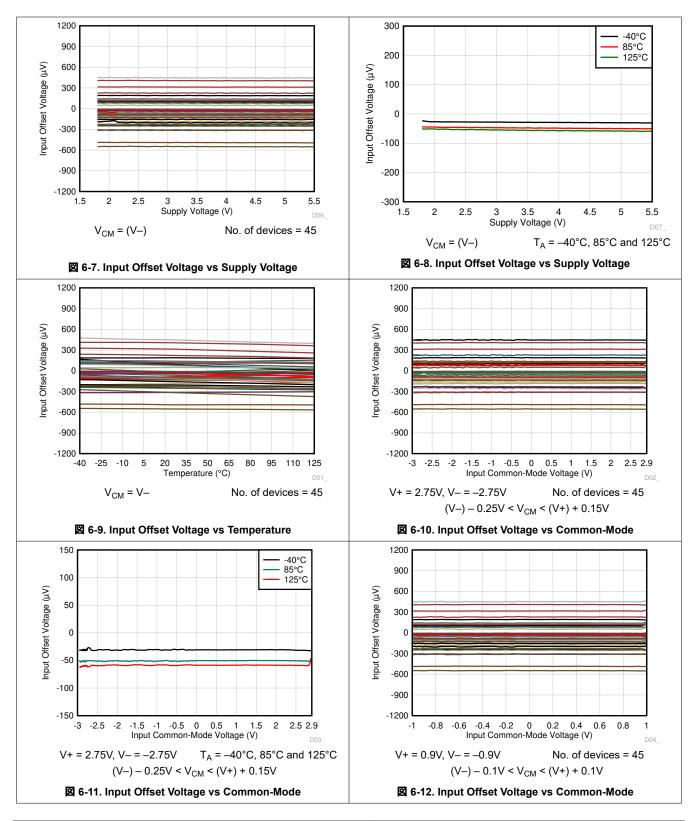


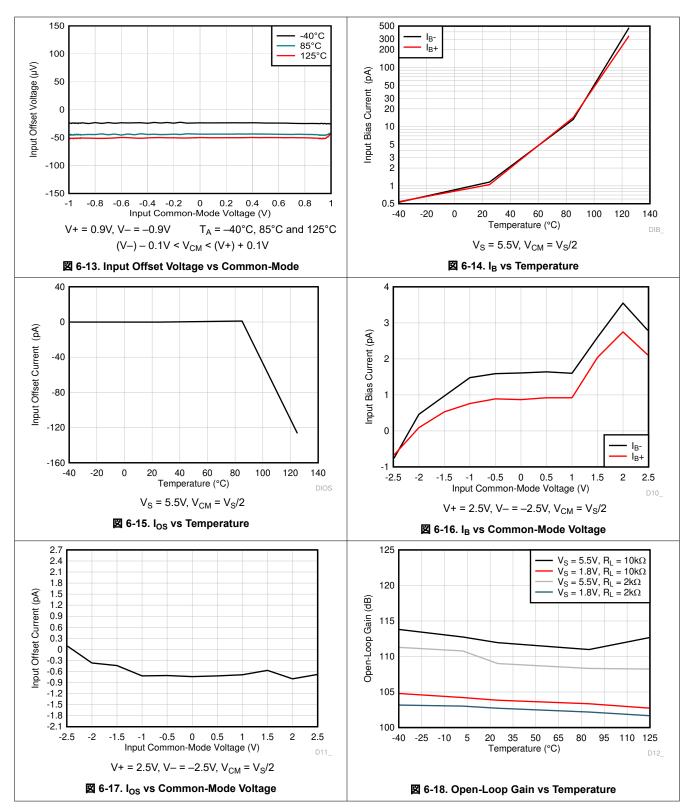
- (3) Third-order filter; bandwidth = 80kHz at -3dB.
- (4) Short circuit current specified here is average of sourcing and sinking short circuit currents
- (5) Disable time (t_{OFF}) and enable time (t_{ON}) are defined as the time interval between the 50% point of the signal applied to the SHDN pin and the point at which the output voltage reaches the 10% (disable) or 90% (enable) level.
- (6) Full shutdown refers to the dual device having both channels 1 and 2 disabled (SHDN1 = SHDN2 = V-) and the quad device having all channels 1 to 4 disabled (SHDN12 = SHDN34 = V-). For partial shutdown, only one SHDN pin is exercised; in this mode, the internal biasing circuitry remains operational and the enable time is shorter.
- (7) Shutdown section is on preview

6.8 Typical Characteristics

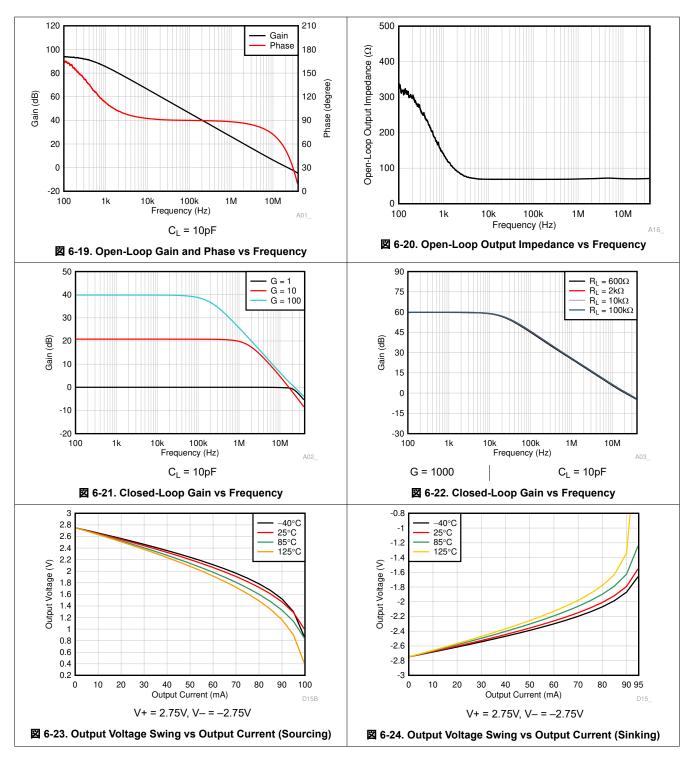


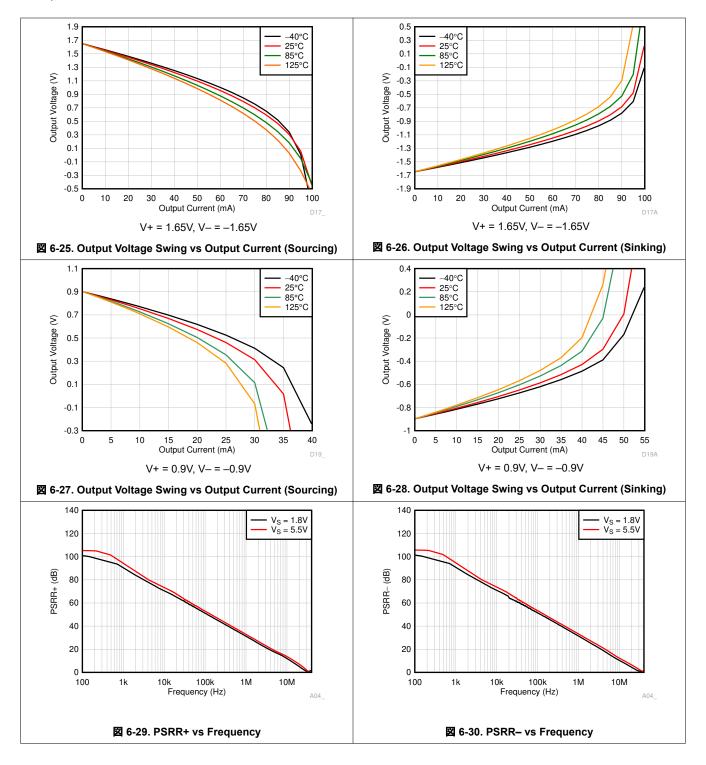




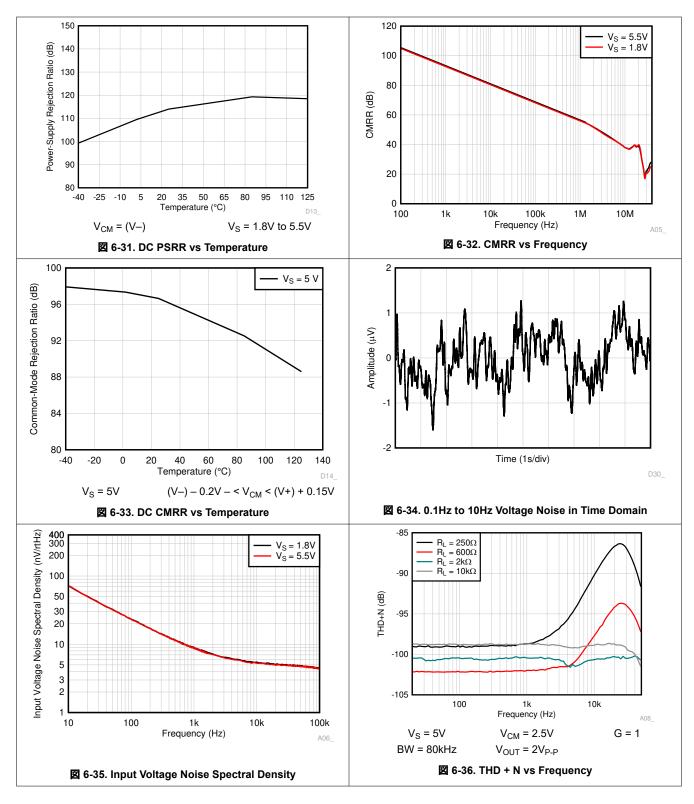


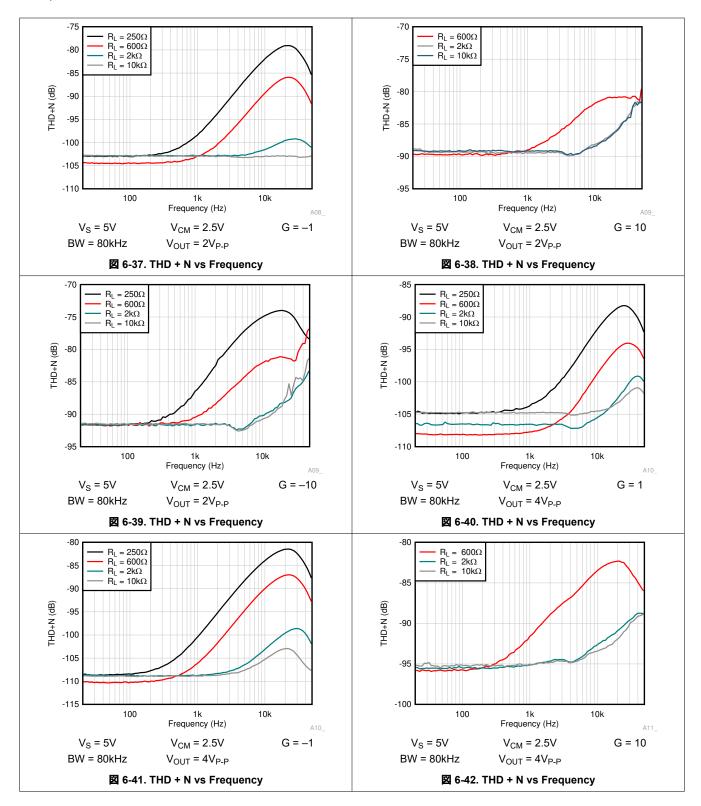




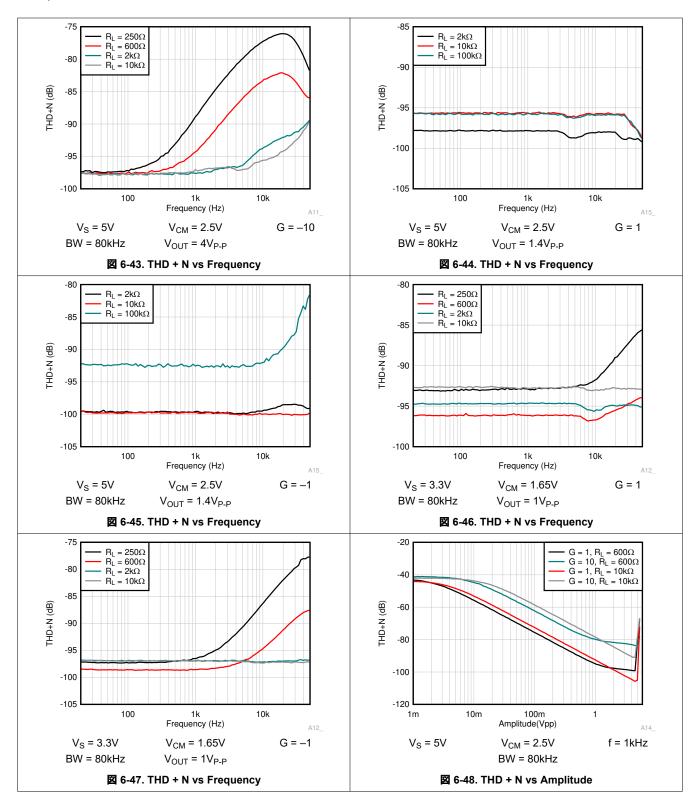


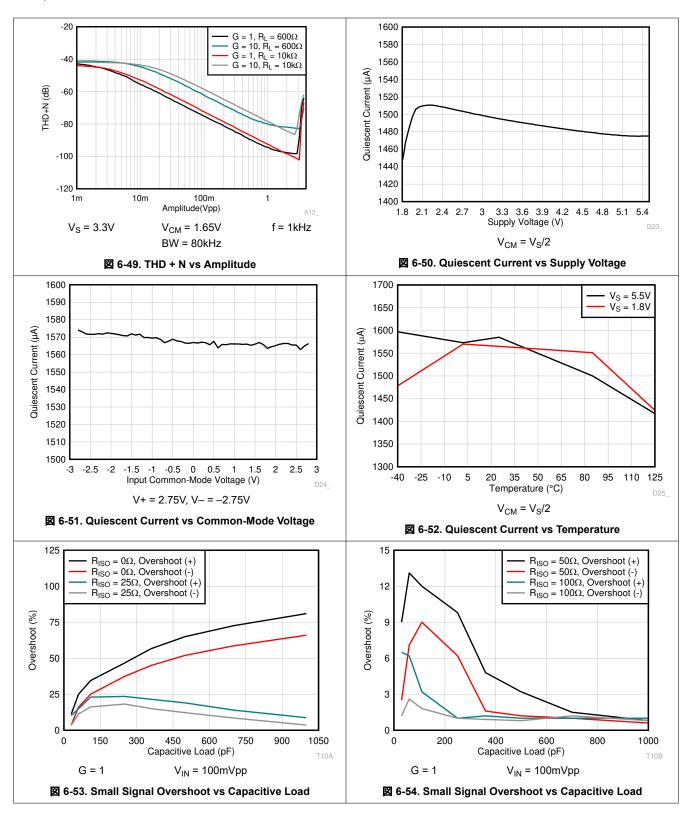




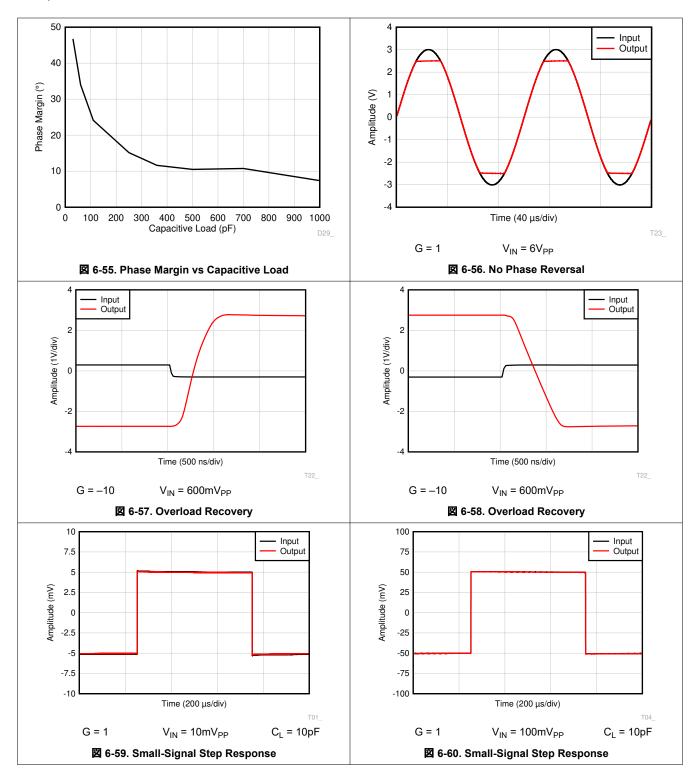


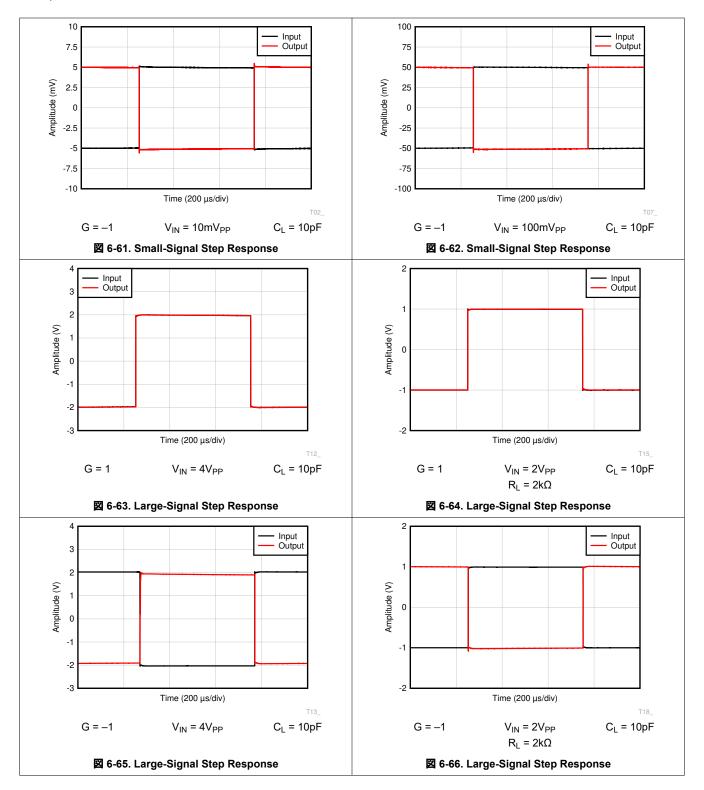




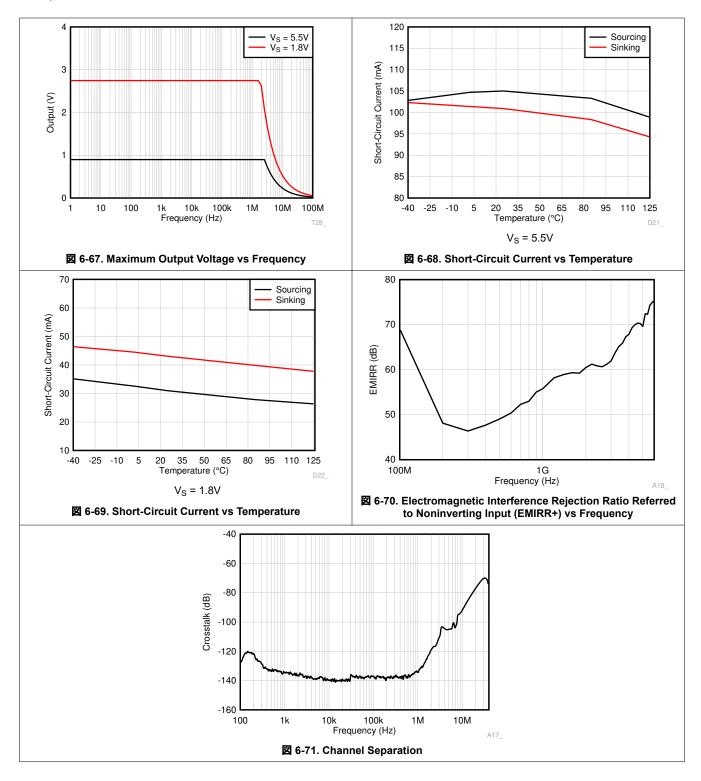














7 Detailed Description

7.1 Overview

The OPAx323 family of op amps includes single / dual / quad channel (OPA323, OPA2323, OPA4323), ultra low-voltage (1.7V to 5.5V), high-bandwidth (20MHz) amplifiers. This family of amplifiers feature a zero-crossover input stage and a rail-to-rail output stage that can be used for variety of applications across industrial and automotive markets. The input common-mode voltage range includes signal swing beyond the supply rails, and allows the OPAx323 to be used in many single-supply or dual supply configurations. Rail-to-rail output swing significantly increases dynamic range, especially in low-supply applications with the class AB output stage capable of driving smaller resistive loads.

The OPAx323 family of zero-cross input stage amplifiers achieve high linearity for input signals with rail-to-rail swing that are typical in ADC driver applications in comparison to the complementary input stage amplifiers. Gain-bandwidth of 20MHz helps provide a fast settling response for ADC sampling speeds between 0.5 to 5MSPS depending on the settling performance required. The OPAx323 easily supports precision performance in high gain voltage sensing applications (such as the wheatsone bridge), as the device features maximum offset of 1.25 mV and drift of $1.8 \mu \text{V/}^{\circ}\text{C}$. This unique combination of high precision and high gain-bandwidth enables use in multiple applications such as the motor rotary encoders, microphone audio pre-amplifiers and ultrasonic transducers.

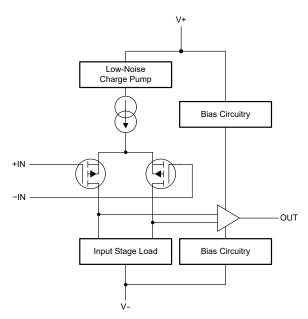
The OPAx323 family consumes only 1.6mA supply current per channel for 20MHz gain bandwidth, thus providing a good AC performance at a very low power consumption. These devices achieve a high slew-rate of $33V/\mu s$ allowing for fast detection of faults in motor current sensing applications. The zero-cross over input stage provides identical AC and DC performance for both low and high-side sensing applications, thus making the OPAx323 the best choice for current sensing in a variety of end equipments such as the solar string inverters, power delivery, grid, and EV infrastructure. Precision transimpedance and voltage gain applications are well served with a low input bias current (0.5pA typical, 20pA maximum), a good PSRR ($20\mu V/V$ maximum), CMRR (100dB minimum), and A_{OL} (114dB minimum). The device has 60° of typical phase margin with no load and drives up to 75pF with a phase margin of 35° .

The OPAx323 has an internal current limit that enables additional robustness when operating with high output current while driving smaller output impedance like 68Ω , 128Ω , and 256Ω loads in audio applications. The OPAx323 can swing very close to the rails and has a short circuit current of ± 80 mA minimum at 5.5V power supply. The OPAx323S devices provide shutdown functionality for additional power savings and help disable the amplifier when idle. These op amps feature an integrated radio frequency immunity (RFI) and electro-magnetic interference (EMI) rejection filter, unity-gain stability, and no-phase reversal in input overdrive conditions.

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7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Operating Voltage

The OPAx323 series of operational amplifiers is fully specified from 1.8V to 5.5V and is designed for amplifier operation from 1.7V to 1.8V. In addition, many specifications apply from -40° C to 125°C. Parameters that vary significantly with operating voltages or temperature are provided in the *Typical Characteristics* section. TI highly recommends to add low-ESR ceramic bypass capacitors (C_{BYP}) between each supply pin and ground. Only one C_{BYP} is sufficient for single supply operation. Make sure that C_{BYP} is placed as close to the device as possible and the power supply trace routes through C_{BYP} before reaching the amplifier power supply terminals.

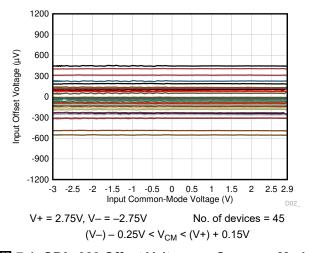
7.3.2 Rail-to-Rail Input

The input common-mode voltage range of the OPAx323 series extends beyond the supply rails with a common-mode rejection ratio (CMRR) of 100dB minimum at 5.5V as specified in *Electrical Characteristics*. The device is designed to have a good performance of 85dB minimum CMRR even when operating at an ultra-low supply voltage of 1.8V. This is made possible by using a zero-cross input stage architecture for the amplifier input pair.

Most commercial amplifiers employ a complementary input stage architecture which often limits the rail-to-rail CMRR to less than 65dB. This is because the offset performance across the rail-to-rail input common-mode range is not linear. One of the input pairs, usually, the P-channel pair with better offset, noise performance is designed to cover the majority of the common-mode range with the N-channel pair slated to slowly take over at a certain threshold voltage from the positive rail. The creates a big jump in the offset voltage across common mode when transitioning across the input pairs as shown in TLV900x Offset Voltage vs Common-Mode. This offset jump not only affects CMRR but also limits linearity / THD for rail-to-rail input signals.

The OPAx323 achieves linear offset performance over the entire rail-to-rail input range by extending the common-mode-range of a single P-channel input pair using an internal charge pump as shown in the *Functional Block Diagram*. This eliminates the need for the N-channel input pair and the resulting offset jump caused by input pair transitions.

The OPAx323 exhibits near to zero shift in offset voltage across the entire common-mode voltage as shown in \boxtimes 7-1. This is crucial to achieving high linearity in ADC driver and audio driver applications.



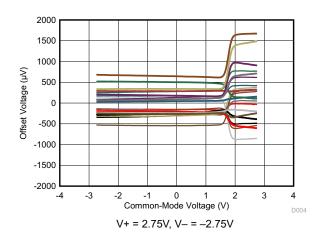


図 7-2. TLV900x Offset Voltage vs Common-Mode

図 7-1. OPAx323 Offset Voltage vs Common-Mode

7.3.3 Rail-to-Rail Output

The OPAx323 delivers a robust output drive capability. An output stage with common-source transistors is used to achieve full rail-to-rail output swing capability. The device is designed to have a minimum output short circuit current of ±80mA, making the device an excellent choice for audio driver applications at room temperature and

at 5.5V. For resistive loads up to $2k\Omega$ and a power supply of 5.5V, the output swings within a maximum of 55mV to either supply rail, thereby using almost the entire input range of an ADC in ADC driver applications.

7.3.4 Common-Mode Rejection Ratio (CMRR)

The OPAx323 achieves excellent DC and AC CMRR performance. The device is designed to have a DC CMRR performance at two supply voltages (5.5V and 1.8V) for the entire operating temperature range (-40° C to 125°C). DC CMRR is specified for common-mode beyond rails over a input voltage range of (V–) – 0.2V \leq V_{CM} \leq (V+) + 0.15V for 5.5V operation and (V–) – 0.1V \leq V_{CM} \leq (V+) + 0.05V for 1.8V operation. AC CMRR is shown in *Typical Characteristics* and is subject to the routing of input traces on the PCB board. For good performance, maintain a short and symmetrical input trace for the two amplifier input terminals.

7.3.5 Capacitive Load and Stability

The OPAx323 is designed for use in applications where driving a capacitive load is required. As with all operational amplifiers, there can be specific instances where the device can become unstable. The particular operational amplifier circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether or not an amplifier is stable in operation.

An operational amplifier in the unity-gain (1V/V) buffer configuration that drives a capacitive load exhibits a greater tendency to be unstable than an amplifier operating at a higher noise gain. The capacitive load, in conjunction with the operational amplifier output resistance, creates a pole within the feedback loop that degrades the phase margin. The degradation of the phase margin increases when capacitive loading increases. When operating in the unity-gain configuration, the OPAx323 has a phase margin of 50° with 30pF of capacitive load. The device remains stable with pure capacitive loads up to approximately 75pF with acceptable phase margin of 35° and has no sustained oscillations up to 150pF. The equivalent series resistance (ESR) of some very large capacitors (greater than $1\mu F$) is sometimes sufficient to alter the phase characteristics in the feedback loop such that the amplifier remains stable. Increasing the amplifier closed-loop gain allows the amplifier to drive increasingly larger capacitance. This increased capability is evident when measuring the overshoot response of the amplifier at higher voltage gains.

One technique for increasing the capacitive load drive capability of the amplifier operating in a unity-gain configuration is to insert a small resistor (typically 10Ω to 50Ω) in series with the output, as shown in \boxtimes 7-3. This resistor significantly reduces the overshoot and ringing associated with large capacitive loads. This is usually the circuit configuration used in ADC driver application with C_{load} serving as a charge bucket for the ADC sampling capacitor.

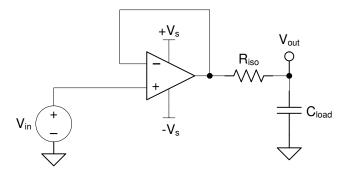


図 7-3. Improving Capacitive Load Drive

7.3.6 Overload Recovery

Overload recovery is defined as the time required for the operational amplifier output to recover from a saturated state to a linear state. The output stage of the operational amplifier enters a saturation region when the output voltage exceeds the rated operating voltage, because of the high input voltage or high gain. After one of the outputs enters the saturation region, the output stage requires additional time to return to the linear operating state which is referred to as overload recovery time. After the output stage returns to linear operating state, the

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amplifier begins to slew at the specified slew rate. Therefore, the propagation delay (in case of an overload condition) is the sum of the overload recovery time and the slew time.

The overload recovery time for the OPAx323 family is designed to be approximately 130ns typical.

7.3.7 EMI Rejection

The OPAx323 uses integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI from sources such as wireless communications (radio frequency interference - RFI) and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the OPAx323 benefits from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10MHz to 6GHz. 図 7-4 shows the results of this testing on the OPAx323. 表 7-1 shows the EMIRR IN+ values for the OPAx323 at particular frequencies commonly encountered in real-world applications. The *EMI Rejection Ratio of Operational Amplifiers* application report contains detailed information on the topic of EMIRR performance relating to op amps and is available for download from www.ti.com.

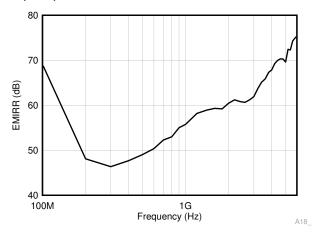


図 7-4. EMIRR Testing



| 表 7-1. | OPAx323 | EMIRR | IN+ for | Frea | uencies | of Interest |
|--------|---------|--------------|---------|------|---------|-------------|
|--------|---------|--------------|---------|------|---------|-------------|

| FREQUENCY | APPLICATION OR ALLOCATION | EMIRR IN+ |
|-----------|--|-----------|
| 400MHz | Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications | 48dB |
| 900MHz | 900MHz Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6GHz), GSM, aeronautical mobile, UHF applications | |
| 1.8GHz | GSM applications, mobile personal communications, broadband, satellite, L-band (1GHz to 2GHz) | 60dB |
| 2.4GHz | 802.11b, 802.11g, 802.11n, Bluetooth®, mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2GHz to 4GHz) | 61dB |
| 3.6GHz | Radiolocation, aero communication and navigation, satellite, mobile, S-band | 67dB |
| 5GHz | 802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4GHz to 8GHz) | 70dB |

7.3.8 ESD and Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect them from accidental ESD events both before and during product assembly.

Having a good understanding of this basic ESD circuitry and relevance to an electrical overstress event is helpful. Z 7-5 shows the ESD circuits contained in the OPAx323 devices. The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power supply lines, where the input and output pins meet at an absorption device internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

Note that the OPAx323 features no current-steering diodes connected between the input and positive power-supply pin.

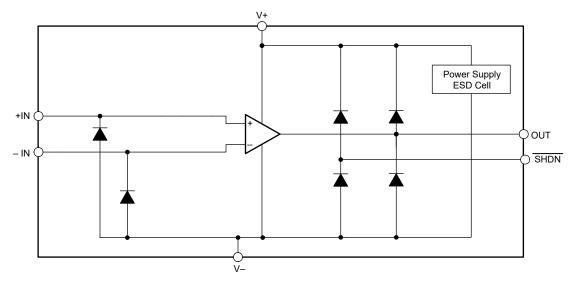


図 7-5. Equivalent Internal ESD Circuitry

7.3.9 Input ESD Protection

The OPAx323 family incorporates internal ESD protection circuits on all pins. For inputs, this protection primarily consists of fail safe ESD input structures which feature no current-steering diodes connected between the input and positive power-supply pin as shown in the \boxtimes 7-5. This feature is very useful during power sequencing scenarios where input signal can be present before the positive power supply rail. A fail safe input ESD structure

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prevents any short between inputs and positive power supply. For further details, refer to *Op Amp ESD Protection Structures* application note.

7.3.10 Shutdown Function

The OPAx323S devices feature SHDN pins that disable the op amp, placing the op amp into a low-power standby mode. In this mode, the op amp typically consumes less than 1000nA at room temperature. The SHDN pins are active low, meaning that shutdown mode is enabled when the input to the SHDN pin is a valid logic low.

The \overline{SHDN} pins are referenced to the negative supply voltage of the op amp. The threshold of the shutdown feature lies around 500mV (typical) and does not change with respect to the supply voltage. Hysteresis has been included in the switching threshold to provide for smooth switching characteristics. For optimal shutdown behavior, the \overline{SHDN} pins must be driven with valid logic signals. A valid logic low is defined as a voltage between V– and (V–) + 0.2V. A valid logic high is defined as a voltage between (V–) + 1V and V+. To enable the amplifier, the \overline{SHDN} pins must be driven to a valid logic high. To disable the amplifier, the \overline{SHDN} pins must be driven to a valid logic low. TI highly recommends to not leave the shutdown pin floating, but to connect the shutdown pin to a valid high or low voltage. The maximum voltage allowed at the \overline{SHDN} pins is (V+) + 0.5V. Exceeding this voltage level damages the device.

The \overline{SHDN} pins are high-impedance CMOS inputs. Dual op amp versions are independently controlled and quad op amp versions are controlled in pairs with logic inputs. For battery-operated applications, this feature can be used to greatly reduce the average current and extend battery life. The enable and disable time is targeted to be under 1µs for full shutdown of all channels. When disabled, the output assumes a high-impedance state. This architecture allows the OPAx323S to operate as a gated amplifier (or to have the device output multiplexed onto a common analog output bus). Shutdown time (t_{OFF}) depends on loading conditions as any charge on the output capacitor needs to be discharged by any external resistive load or the op-amp. To achieve the 1µs shutdown time, the specified $10k\Omega$ load to midsupply (V_S / 2) is required with no capacitive load.



7.3.11 Packages with an Exposed Thermal Pad

The OPAx323 family is available in packages such as the WQFN-16 (RTE) and WSON-8 (DSG), which feature an exposed thermal pad. Inside the package, the die is attached to this thermal pad using an electrically conductive compound. For this reason, when using a package with an exposed thermal pad, the thermal pad must be connected to V-. Attaching the thermal pad to a potential other then V- is not allowed, and the performance of the device may not be consistent with the *Electrical Characteristics* table when doing so.

7.4 Device Functional Modes

The OPAx323 devices have one functional mode. These devices are powered on as long as the power-supply voltage is between 1.7V $(\pm 0.85\text{V})$ and 5.5V $(\pm 2.75\text{V})$.

The OPAx323S devices feature a shutdown pin, which can be used to place the op amp into a low-power mode. For more information, see the *Shutdown Function* section.



8 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The OPAx323 family of rail-to-rail input and output operational amplifiers is specifically designed for variety of high gain and high speed applications. These devices operate from 1.7V to 5.5V, are unity-gain stable, and are also an excellent choice for a wide range of general-purpose applications. The output stage is capable of driving small resistive loads connected to any point between V+ and V− as long as the device is not forced into short circuit mode. The input common-mode voltage range includes beyond the rail signal swing and allows the OPAx323 series to be used in many single-supply or dual supply configurations.

8.2 Typical Application

8.2.1 OPAx323 in Low-Side, Current Sensing Application

図 8-1 shows the OPA323 configured in a low-side current sensing application.

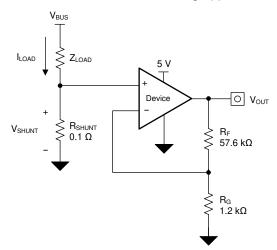


図 8-1. OPA323 in a Low-Side, Current-Sensing Application

8.2.1.1 Design Requirements

The design requirements for this design are:

Load current: 0A to 1A

Maximum output voltage: 4.9VMaximum shunt voltage: 100mV

8.2.1.2 Detailed Design Procedure

The transfer function of the circuit in \boxtimes 8-1 is given in \rightrightarrows 1.

$$V_{OUT} = I_{LOAD} \times R_{SHUNT} \times Gain$$
 (1)

The load current (I_{LOAD}) produces a voltage drop across the shunt resistor (R_{SHUNT}). The load current is set from 0A to 1A. To keep the shunt voltage below 100 mV at maximum load current, the largest shunt resistor is defined using $\gtrsim 2$.

$$R_{SHUNT} = \frac{V_{SHUNT_MAX}}{I_{LOAD_MAX}} = \frac{100 \text{ mV}}{1 \text{ A}} = 100 \text{ m}\Omega$$
 (2)

Using $\stackrel{\prec}{\rightrightarrows}$ 2, R_{SHUNT} is calculated to be 100mΩ. The voltage drop produced by I_{LOAD} and R_{SHUNT} is amplified by the OPA323 to produce an output voltage of approximately 0V to 4.9V. The gain needed by the OPA323 to produce the necessary output voltage is calculated using $\stackrel{\prec}{\rightrightarrows}$ 3.

$$Gain = \frac{V_{OUT_MAX} - V_{OUT_MIN}}{V_{IN_MAX} - V_{IN_MIN}}$$
(3)

Using $\not \equiv 3$, the required gain is calculated to be 49V/V, which is set with resistors R_F and R_G. $\not \equiv 4$ sizes the resistors R_F and R_G, to set the gain of the OPA323 to 49V/V.

$$Gain = 1 + \frac{R_F}{R_C} \tag{4}$$

Selecting R_F as 57.6k Ω and R_G as 1.2k Ω provides a combination that equals 49V/V. \boxtimes 8-2 shows the measured transfer function of the circuit shown in \boxtimes 8-1. Notice that the gain is only a function of the feedback and gain resistors. This gain is adjusted by varying the ratio of the resistors and the actual resistors values are determined by the impedance levels that the designer wants to establish. The impedance level determines the current drain, the effect that stray capacitance has, and a few other behaviors. There is no optimal impedance selection that works for every system; choose an impedance that is best for the system parameters.

8.2.1.3 Application Curve

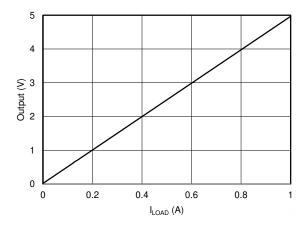


図 8-2. Low-Side, Current-Sense Transfer Function

8.3 Power Supply Recommendations

The OPAx323 is tested for amplifier operation at 1.7V and is fully specified from 1.8V to 5.5V (±0.9V to ±2.75V); many specifications apply from –40°C to 125°C. *Electrical Characteristics* presents parameters that can exhibit significant variance regarding operating voltage or temperature.

注意

Supply voltages larger than 7V can permanently damage the device; for more information, see the *Absolute Maximum Ratings* table.

TI highly recommends to add low-ESR ceramic bypass capacitors (C_{BYP}) between each supply pin and ground. Only one C_{BYP} is sufficient for single supply operation. Place the C_{BYP} as close to the device as possible to reduce coupling errors from noisy or high-impedance power supplies. Make sure the power supply trace routes through C_{BYP} before reaching the amplifier power supply terminals. For more information, see *Layout Guidelines*.

8.4 Layout

8.4.1 Layout Guidelines

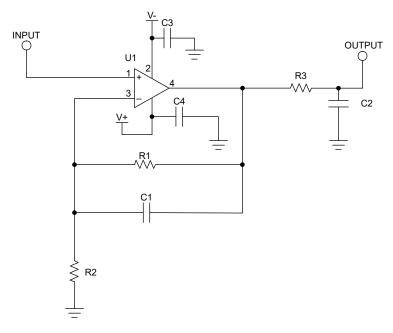
For best operational performance, use good printed circuit board (PCB) layout practices, including:

- Noise can propagate into analog circuitry through the power connections of the board and propagate to the
 power pins of the op amp itself. Bypass capacitors are used to reduce the coupled noise by providing a lowimpedance path to ground.
 - Connect low-ESR, 0.1µF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. One bypass capacitor from V+ to ground is adequate for single-supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most effective
 methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes.
 A ground plane helps distribute heat and reduces electromagnetic interference (EMI) noise pickup. Take care
 to physically separate digital and analog grounds, paying attention to the flow of the ground current.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If
 these traces cannot be kept separate, then cross the sensitive trace at a 90 degree angle, which is much
 better as opposed to running the traces in parallel with the noisy trace.
- Place the external components as close to the device as possible, as shown in Layout Example. Keeping R₁ and R₂ close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- TI recommends cleaning the PCB following board assembly for best performance.
- Any precision integrated circuit can experience performance shifts resulting from moisture ingress into the
 plastic package. Following any aqueous PCB cleaning process, TI recommends baking the PCB assembly to
 remove moisture introduced into the device packaging during the cleaning process. A low-temperature, postcleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

English Data Sheet: SBOSAE8



8.4.2 Layout Example



Note: C3 and C4 are C_{BYP} capacitors

図 8-3. Schematic for Noninverting Configuration Layout Example

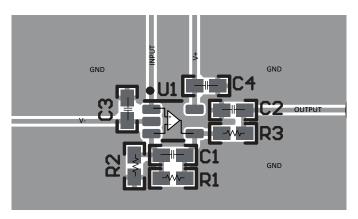


図 8-4. Operational Amplifier Board Layout for Noninverting Configuration - SC70 (DCK) Package



9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, QFN/SON PCB Attachment application note
- Texas Instruments, Quad Flatpack No-Lead Logic Packages application note

9.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。 変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

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9.5 用語集

テキサス・インスツルメンツ用語集

この用語集には、用語や略語の一覧および定義が記載されています。

10 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

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資料に関するフィードバック(ご意見やお問い合わせ)を送信



| • | Changed the EMIRR IN+ values for the 900MHz, 1.8GHz, 2.4GHz, 3.6GHz, and 5GHz frequency options in |
|---|--|
| | OPAx323 EMIRR IN+ for Frequencies of Interest table |

| * (October 2023) to Revision A (November 2023) | Page |
|--|------|
| 23 のステータスをプレビューからアクティブに変更 | 1 |
| 3のステータスをプレビューからアクティブに変更 | 1 |
| | |

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|--------------|-------------------------------|--------------------|--------------|----------------------|---------|
| OPA2323IDDFR | ACTIVE | SOT-23-THIN | DDF | 8 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | 23DDF | Samples |
| OPA2323IDGKR | ACTIVE | VSSOP | DGK | 8 | 2500 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | 2DGK | Samples |
| OPA2323IDR | ACTIVE | SOIC | D | 8 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | 2323ID | Samples |
| OPA323IDCKR | ACTIVE | SC70 | DCK | 5 | 3000 | RoHS & Green | SN | Level-1-260C-UNLIM | -40 to 125 | 1RG | Samples |
| OPA4323IDYYR | ACTIVE | SOT-23-THIN | DYY | 14 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | O4323IDYYR | Samples |
| OPA4323IPWR | ACTIVE | TSSOP | PW | 14 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | O4323PW | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

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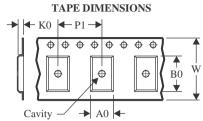
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TAPE AND REEL INFORMATION





| | Dimension designed to accommodate the component width |
|----|---|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

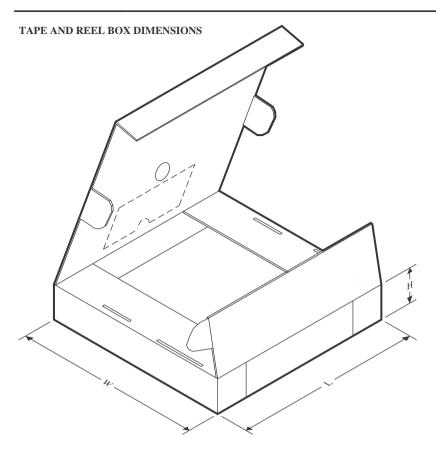


*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| OPA2323IDDFR | SOT-23- THIN | DDF | 8 | 3000 | 180.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| OPA2323IDGKR | VSSOP | DGK | 8 | 2500 | 330.0 | 12.4 | 5.3 | 3.4 | 1.4 | 8.0 | 12.0 | Q1 |
| OPA2323IDR | SOIC | D | 8 | 3000 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| OPA323IDCKR | SC70 | DCK | 5 | 3000 | 178.0 | 9.0 | 2.4 | 2.5 | 1.2 | 4.0 | 8.0 | Q3 |
| OPA4323IDYYR | SOT-23- THIN | DYY | 14 | 3000 | 330.0 | 12.4 | 4.8 | 3.6 | 1.6 | 8.0 | 12.0 | Q3 |
| OPA4323IPWR | TSSOP | PW | 14 | 3000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |



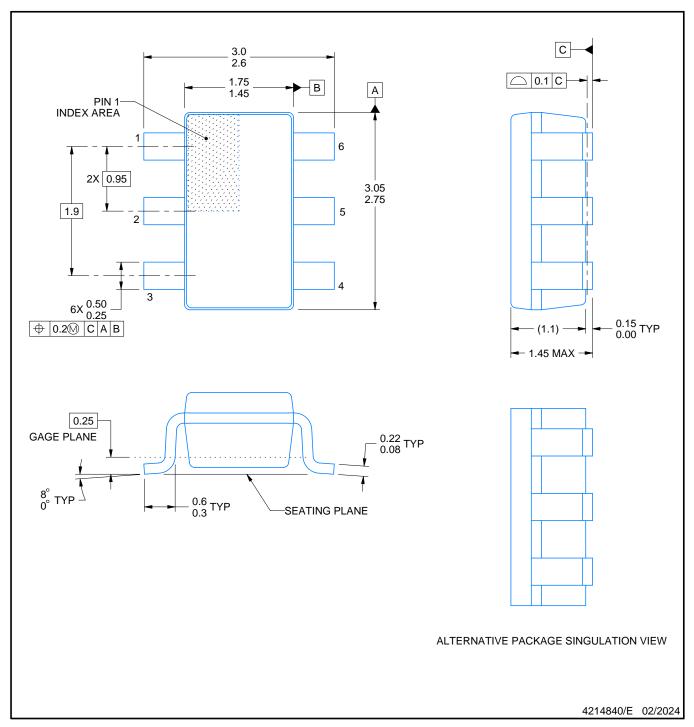
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*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| OPA2323IDDFR | SOT-23-THIN | DDF | 8 | 3000 | 210.0 | 185.0 | 35.0 |
| OPA2323IDGKR | VSSOP | DGK | 8 | 2500 | 356.0 | 356.0 | 35.0 |
| OPA2323IDR | SOIC | D | 8 | 3000 | 356.0 | 356.0 | 35.0 |
| OPA323IDCKR | SC70 | DCK | 5 | 3000 | 190.0 | 190.0 | 30.0 |
| OPA4323IDYYR | SOT-23-THIN | DYY | 14 | 3000 | 336.6 | 336.6 | 31.8 |
| OPA4323IPWR | TSSOP | PW | 14 | 3000 | 356.0 | 356.0 | 35.0 |





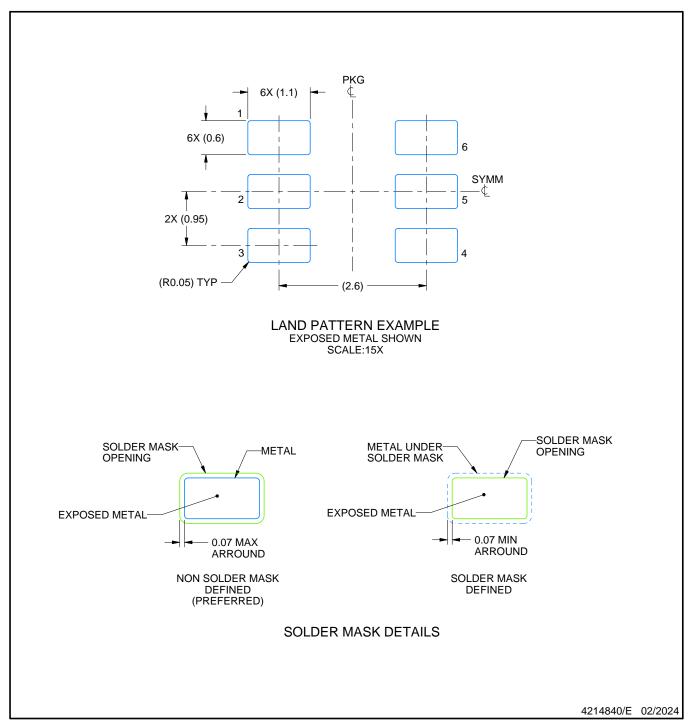
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- 5. Refernce JEDEC MO-178.



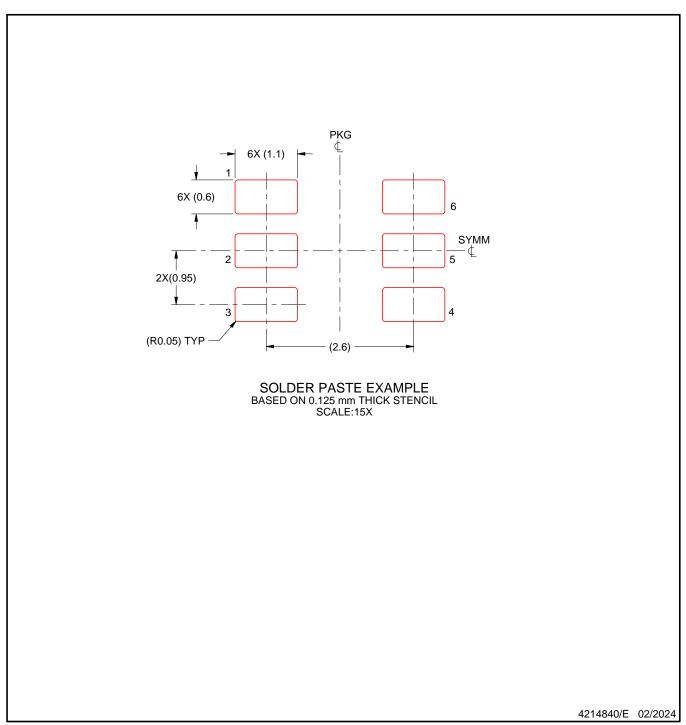


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

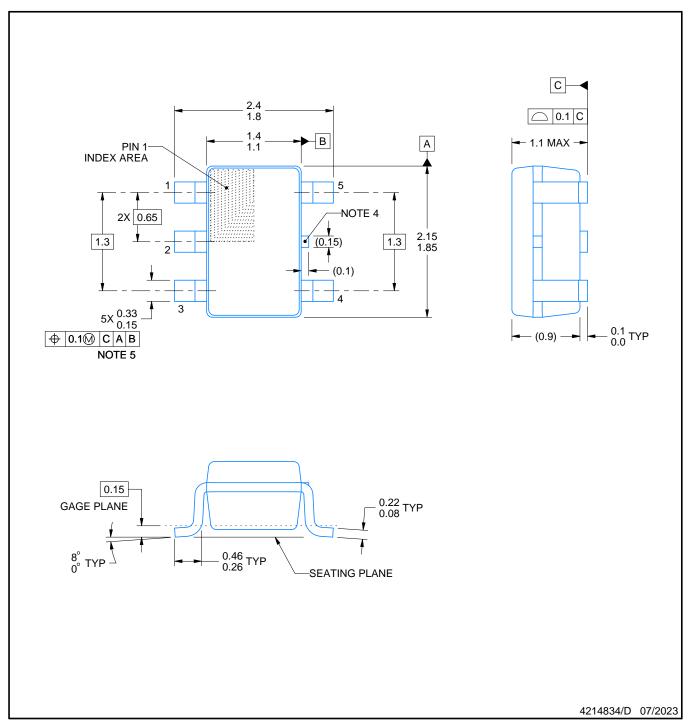




- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







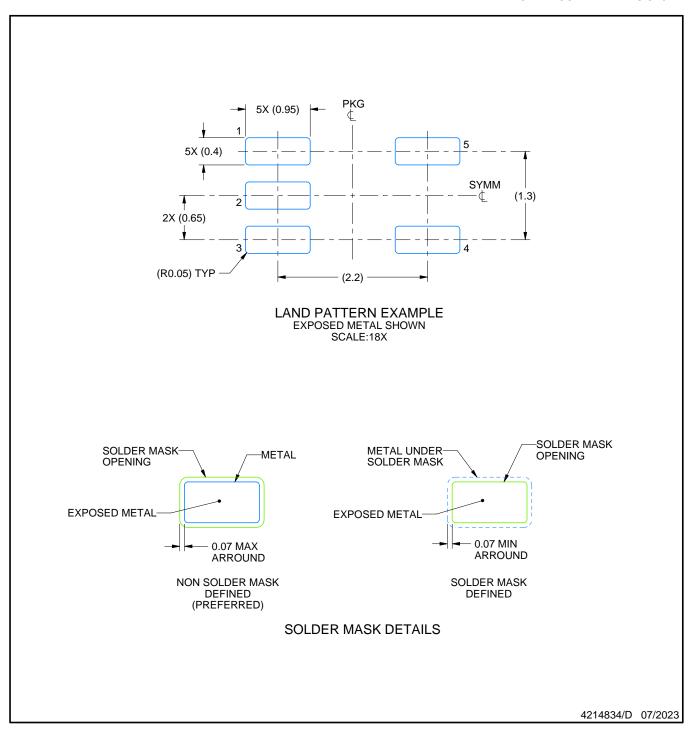
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Reference JEDEC MO-203.

- 4. Support pin may differ or may not be present.5. Lead width does not comply with JEDEC.

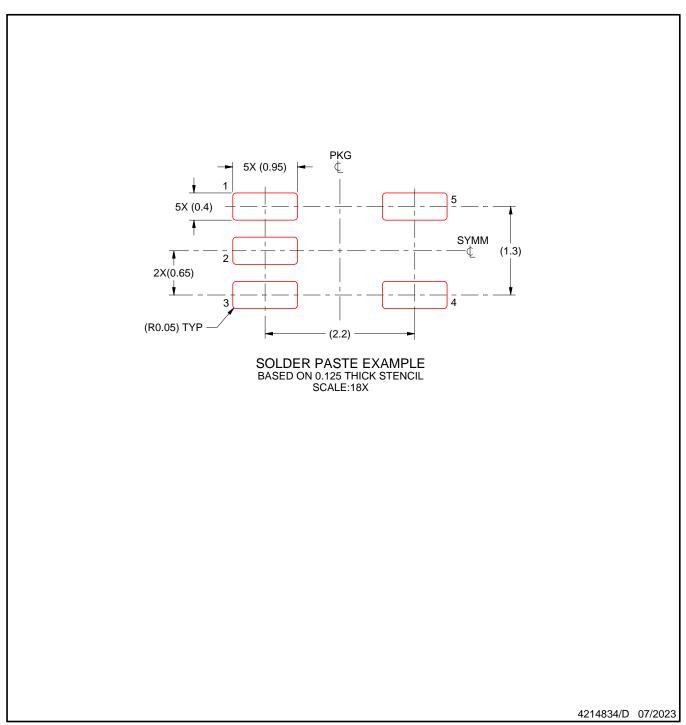




NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



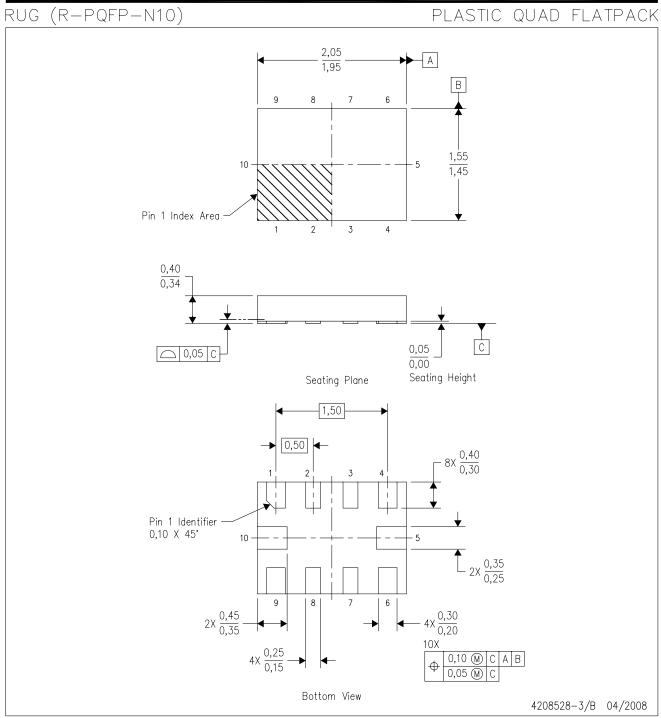
PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153





NOTES: All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
 C. QFN (Quad Flatpack No-Lead) package configuration.
 D. This package complies to JEDEC MO-288 variation X2EFD.





SMALL OUTLINE INTEGRATED CIRCUIT



- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE PACKAGE



PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE



- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



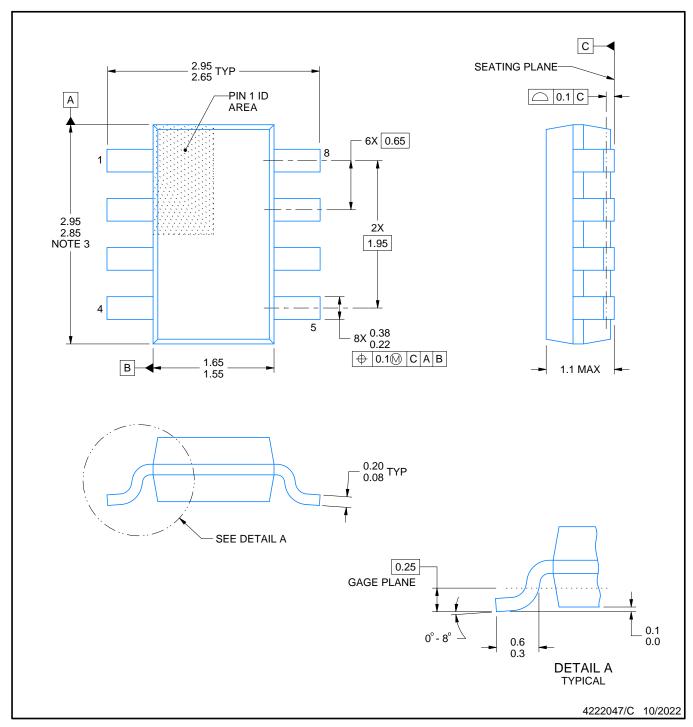
SMALL OUTLINE PACKAGE



- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.





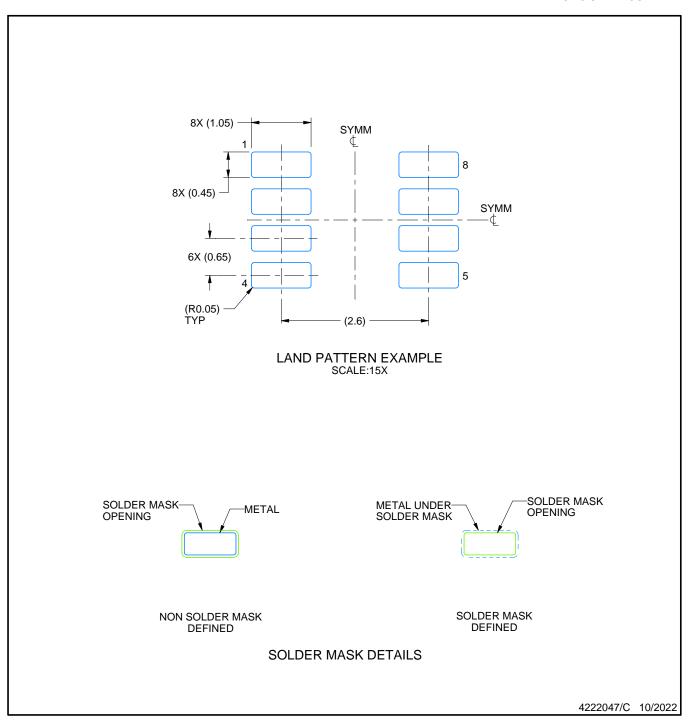


- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

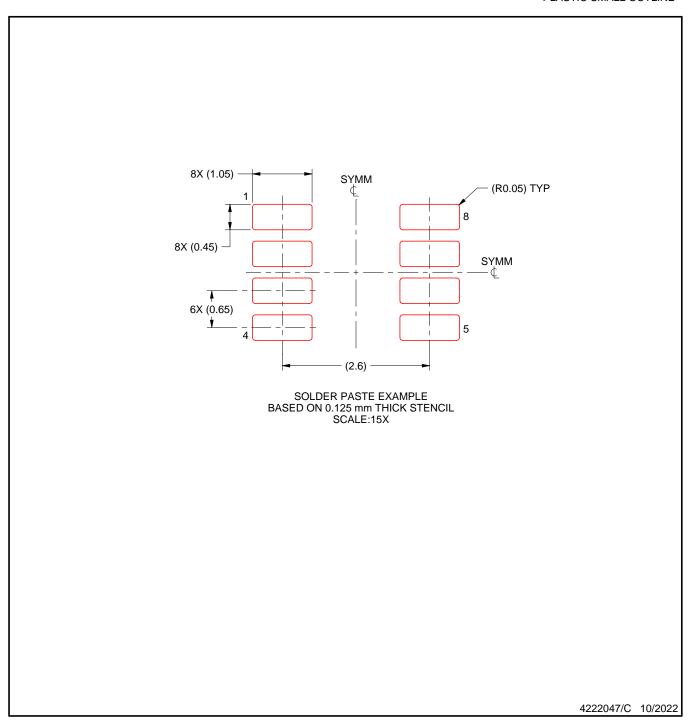
 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.





- 4. Publication IPC-7351 may have alternate designs.
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





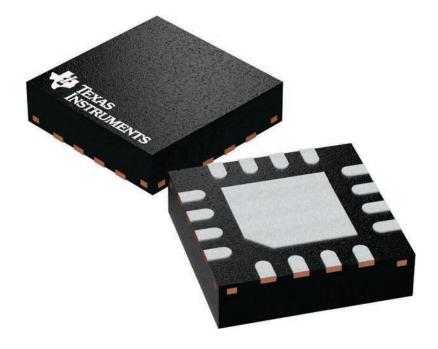
- 6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 7. Board assembly site may have different recommendations for stencil design.

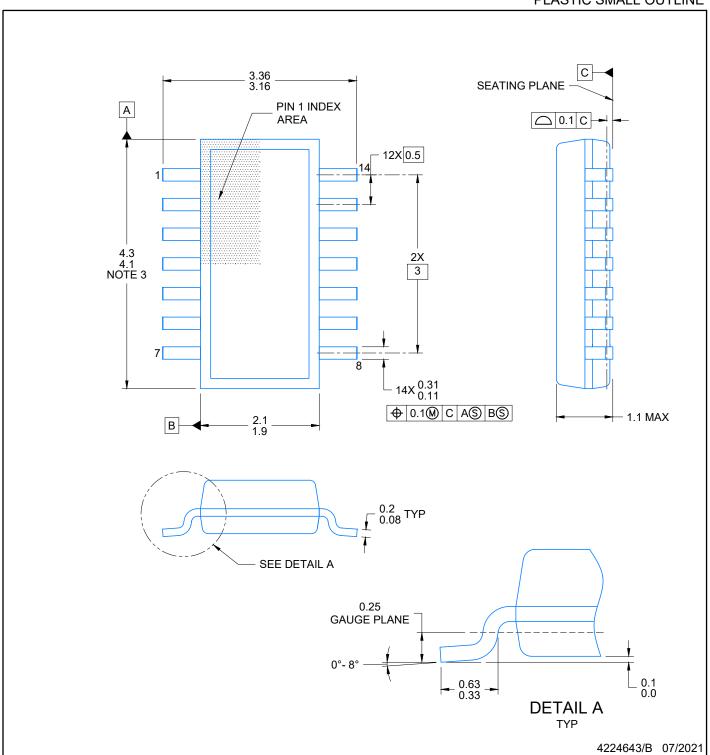


3 x 3, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

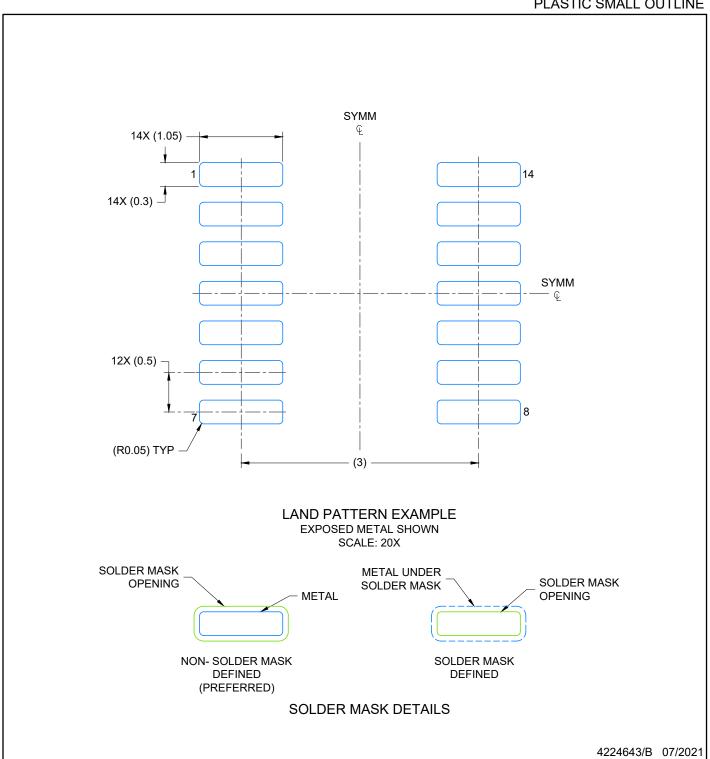
This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





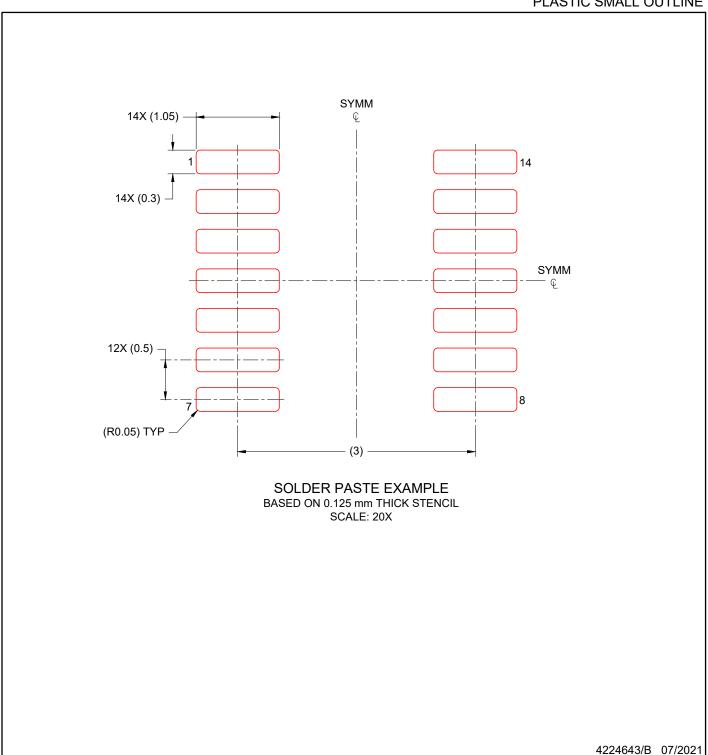
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- 5. Reference JEDEC Registration MO-345, Variation AB





- Publication IPC-7351 may have alternate designs.
- Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- Board assembly site may have different recommendations for stencil design.



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